

# FCC PART 15C TEST REPORT No. **I16Z42280-SRD02**

for

**TCL Communication Ltd.** 

LTE / UMTS / GSM mobile phone

Model Name: 5044O

FCC ID: 2ACCJH063

with

**Hardware Version: PIO** 

**Software Version: v4HA2** 

Issued Date: 2016-12-26



#### Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of CTTL.

#### **Test Laboratory:**

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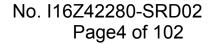
## **REPORT HISTORY**

Report Number	Revision	Description	Issue Date
I16Z42280-SRD02	Rev.0	1st edition	2016-12-26



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A.8. CARRIER FREQUENCY SEPARATION	83
A.9. Number of Hopping Channels	86
A 10 AC POWERLINE CONDUCTED EMISSION	90



## 1. Test Laboratory

## 1.1. Testing Location

Conducted testing Location: CTTL(huayuan North Road)

Address: No. 52, Huayuan North Road, Haidian District, Beijing,

P. R. China100191

Radiated testing Location: CTTL(BDA))

Address: No. 18 Jia Kangding Street, BDA District, Beijing, P. R.

China 100191

### 1.2. <u>Testing Environment</u>

Normal Temperature:  $15-35^{\circ}$ C Relative Humidity: 20-75%

### 1.3. Project data

Testing Start Date: 2016-11-23
Testing End Date: 2016-12-15

## 1.4. Signature

Wu Le

(Prepared this test report)

Sun Zhenyu

(Reviewed this test report)

Li Zhuofang

(Approved this test report)



## 2. Client Information

## 2.1. Applicant Information

Company Name: TCL Communication Ltd.

Address /Post: 5F, C building, No. 232, Liang Jing Road ZhangJiang High-Tech Park,

Pudong Area Shanghai, P.R. China. 201203

City: Shanghai Postal Code: 201203 Country: China

Telephone: 0086-21-31363544 Fax: 0086-21-61460602

## 2.2. Manufacturer Information

Company Name: TCL Communication Ltd.

Address /Post: 5F, C building, No. 232, Liang Jing Road ZhangJiang High-Tech Park,

Pudong Area Shanghai, P.R. China. 201203

City: Shanghai Postal Code: 201203 Country: China

Telephone: 0086-21-31363544 Fax: 0086-21-61460602



## 3. Equipment UnderTest (EUT) and Ancillary Equipment (AE)

## 3.1. About EUT

Description LTE / UMTS / GSM mobile phone

Model Name 5044O

FCC ID 2ACCJH063

Frequency Band ISM 2400MHz~2483.5MHz Type of Modulation GFSK/π/4 DQPSK/8DPSK

Number of Channels 79

Power Supply 3.8V DC by Battery

## 3.2. Internal Identification of EUT

EUT ID*	SN or IMEI	<b>HW Version</b>	SW Version
EUT1	1	PIO	v4HA2
EUT2	1	PIO	v4HA2

<sup>\*</sup>EUT ID: is used to identify the test sample in the lab internally.

## 3.3. Internal Identification of AE

AE ID*	Description	SN
AE1	Battery	16TCT-BA-1280
AE2	Battery	16TCT-BA-1269
AE3	Battery	16TCT-BA-1175
AE4	Battery	16TCT-BA-1270
AE5	Battery	16TCT-BA-1279
AE6	Battery	16TCT-BA-1281
AE7	Battery	1
AE8	USB Cable	15TCT-DC-0208
AE9	USB Cable	16TCT-DC-0017
AE10	USB Cable	16TCT-DC-0459
AE11	Travel charger	16TCT-CH-1359
AE12	Travel charger	16TCT-CH-1360
AE13	Travel charger	16TCT-CH-1176
AE14	Travel charger	16TCT-CH-1180
AE15	Travel charger	16TCT-CH-1318
AE16	Travel charger	16TCT-CH-1313
AE17	Travel charger	16TCT-CH-1274
AE18	Travel charger	16TCT-CH-1271
AE19	Travel charger	16TCT-CH-0744
AE20	Travel charger	16TCT-CH-0742
AE21	Travel charger	16TCT-CH-1592



AE22 Travel charger 16TCT-CH-1590

AE1/AE2/AE3/AE4/AE5/AE6

Model CAB2000070C1

Manufacturer BYD
Capacitance 2000mAh
Nominal voltage 3.8V

AE7

Model CAB2000071C7

Manufacturer VEKEN
Capacitance 2000mAh
Nominal voltage 3.8V

AE8

Model CDA3122005C2 Manufacturer SHENHUA

Length of cable

AE9

Model CDA3122005C1

Manufacturer JUWEI

Length of cable

AE10

Model CDA3122005C8

Manufacturer PUAN Length of cable /

AE11/AE12

Model CBA3068AGAC1

Manufacturer BYD Length of cable /

AE13/AE14

Model CBA3068AGAC3

Manufacturer yingju Length of cable /

AE15/AE16

Model CBA3068AGAC4

Manufacturer Aohai
Length of cable /

AE17/AE18

Model CBA0066AGAC3

Manufacturer yingju Length of cable /

AE19/AE20

Model CBA0066AGAC1

Manufacturer BYD



Length of cable

AE21AE22

Model CBA0066AGAC5

Manufacturer PUAN

Length of cable

## 3.4. Normal Accessory setting

Fully charged battery should be used during the test.

## 3.5. General Description

The Equipment Under Test (EUT) is a model of LTE / UMTS / GSM mobile phone with integrated antenna. It consists of normal options: lithium battery, charger. Manual and specifications of the EUT were provided to fulfill the test.

<sup>\*</sup>AE ID: is used to identify the test sample in the lab internally.



## 4. Reference Documents

## 4.1. Documents supplied by applicant

EUT feature information is supplied by the applicant or manufacturer, which is the basis of testing.

## 4.2. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
	FCC CFR 47, Part 15, Subpart C:	
	15.205 Restricted bands of operation;	
FCC Part15	15.209 Radiated emission limits, general requirements;	2015
	15.247 Operation within the bands 902–928MHz,	
	2400-2483.5 MHz, and 5725-5850 MHz.	
ANSI C63.10	American National Standard of Procedures for	June,2013
ANSI C03. 10	Compliance Testing of Unlicensed Wireless Devices	June,2013



## 5. Test Results

## 5.1. Summary of Test Results

Abbreviations used in this clause:

- **P** Pass, The EUT complies with the essential requirements in the standard.
- **F** Fail, The EUT does not comply with the essential requirements in the standard
- **NA** Not Applicable, The test was not applicable
- NP Not Performed, The test was not performed by CTTL

SUMMARY OF MEASUREMENT RESULTS	Sub-clause	Verdict
Peak Output Power - Conducted	15.247 (b)(1)	Р
Frequency Band Edges	15.247 (d)	Р
Conducted Emission	15.247 (d)	Р
Radiated Emission	15.247, 15.205, 15.209	Р
Time of Occupancy (Dwell Time)	15.247 (a) (1)(iii)	Р
20dB Bandwidth	15.247 (a)(1)	NA
Carrier Frequency Separation	15.247 (a)(1)	Р
Number of hopping channels	15.247 (a)(b)(iii)	Р
AC Powerline Conducted Emission	15.107, 15.207	Р

Please refer to **ANNEX A** for detail.

The measurement is made according to ANSI C63.10.

#### 5.2. Statements

CTTL has evaluated the test cases requested by the applicant /manufacturer as listed in section 5.1 of this report for the EUT specified in section 3 according to the standards or reference documents listed in section 4.2

This model is a variant product which model name is 5044A; all the test result has been derived from test report of 5044A.



## 6. <u>Test Facilities Utilized</u>

**Conducted test system** 

No.	Equipment	Model	Serial Number	Manufacturer	Calibration Period	Calibration Due date
1	Vector Signal Analyzer	FSQ26	200136	Rohde & Schwarz	1 year	2017-10-25
2	Bluetooth Tester	CBT32	100649	Rohde & Schwarz	1 year	2017-10-26
3	LISN	ENV216	101200	Rohde & Schwarz	1 year	2017-07-10
4	Test Receiver	ESCI	100344	Rohde & Schwarz	1 year	2017-03-01
5	Shielding Room	S81	1	ETS-Lindgren	/	/

Radiated emission test system

Na	Radiated emission test system					
No.	Equipment	Model	Serial Number	Manufacturer	Calibration Period	Calibration Due date
1	Test Receiver	ESU26	100235	Rohde & Schwarz	1 year	2017-03-02
2	Loop antenna	HFH2-Z2	829324/00 7	Rohde & Schwarz	3 years	2017-12-16
3	BiLog Antenna	VULB9163	9163-514	Schwarzbeck	3 years	2017-11-24
4	Dual-Ridge Waveguide Horn Antenna	3117	00139065	ETS-Lindgren	3 years	2017-09-21
5	Dual-Ridge Waveguide Horn Antenna	3116	2663	ETS-Lindgren	3 years	2017-06-17
6	Vector Signal Analyzer	FSV	101047	Rohde & Schwarz	1 year	2017-06-28
7	Bluetooth Tester	CBT	101042	Rohde & Schwarz	1 year	2017-03-02



## 7. Measurement Uncertainty

## 7.1. Peak Output Power - Conducted

#### **Measurement Uncertainty:**

Measurement Uncertainty (k=2)	0.66dB
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## 7.2. Frequency Band Edges

### **Measurement Uncertainty:**

#### 7.3. Conducted Emission

### **Measurement Uncertainty:**

Frequency Range	Uncertainty (k=2)
30 MHz ~ 8 GHz	1.22dB
8 GHz ~ 12.75 GHz	1.51dB
12.7GHz ~ 26 GHz	1.51dB

### 7.4. Radiated Emission

## **Measurement Uncertainty:**

Frequency Range	Uncertainty (k=2)
< 1 GHz	4.86dB
> 1 GHz	5.26dB

## 7.5. Time of Occupancy (Dwell Time)

## **Measurement Uncertainty:**

Measurement Uncertainty (k=2)	0.88ms

#### 7.6. 20dB Bandwidth

#### **Measurement Uncertainty:**

Measurement Uncertainty (k=2)	61.936Hz



## 7.7. Carrier Frequency Separation

## **Measurement Uncertainty:**

## 7.8. AC Powerline Conducted Emission

## **Measurement Uncertainty:**

Measurement Uncertainty (k=2)	3.38dB
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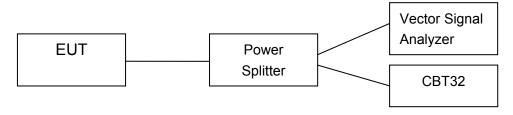
## **ANNEX A: Detailed Test Results**

#### A.1. Measurement Method

#### A.1.1. Conducted Measurements

The measurement is made according to ANSI C63.10.

- 1). Connect the EUT to the test system correctly.
- 2). Set the EUT to the required work mode (Transmitter, receiver or transmitter & receiver).
- 3). Set the EUT to the required channel.
- 4). Set the EUT hopping mode (hopping or hopping off).
- 5). Set the spectrum analyzer to start measurement.
- 6). Record the values. Vector Signal Analyzer



#### A.1.2. Radiated Emission Measurements

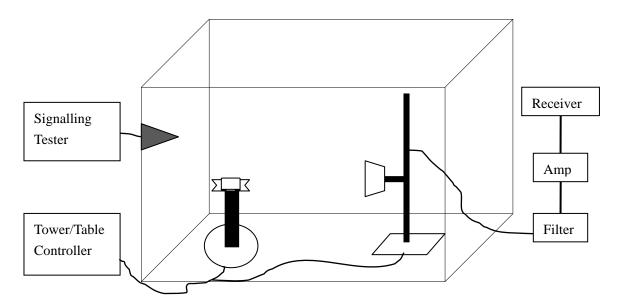
The measurement is made according to ANSI C63.10

The radiated emission test is performed in semi-anechoic chamber. The distance from the EUT to the reference point of measurement antenna is 3m. The test is carried out on both vertical and horizontal polarization and only maximization result of both polarizations is kept. During the test, the turntable is rotated 360° and the measurement antenna is moved from 1m to 4m to get the maximization result.

In the case of radiated emission, the used settings are as follows,

Sweep frequency from 30 MHz to 1GHz, RBW = 100 kHz, VBW = 300 kHz;

Sweep frequency from 1 GHz to 26GHz, RBW = 1MHz, VBW = 1MHz;





## A.2. Peak Output Power - Conducted

### Method of Measurement: See ANSI C63.10-clause 7.8.5

a) Use the following spectrum analyzer settings:

Span: 6MHzRBW: 3MHzVBW: 3MHz

Sweep time: 2.5msDetector function: peak

Trace: max hold

b) Allow trace to stabilize.

c) Use the marker-to-peak function to set the marker to the peak of the emission.

d) The indicated level is the peak output power.

#### **Measurement Limit:**

Standard	Limit (dBm)	
FCC Part 15.247(b)(1)	< 30	

#### Measurement Results:

#### For GFSK

Channel	Ch 0 2402 MHz	Ch 39 2441 MHz	Ch 78 2480 MHz	Conclusion
Peak Conducted				
Output Power	6.43	7.94	6.84	Р
(dBm)				

#### Forπ/4 DQPSK

Channel	Ch 0 2402 MHz	Ch 39 2441 MHz	Ch 78 2480 MHz	Conclusion
Peak Conducted				
Output Power	5.41	6.89	5.88	Р
(dBm)				

#### For 8DPSK

Channel	Ch 0 2402 MHz	Ch 39 2441 MHz	Ch 78 2480 MHz	Conclusion
Peak Conducted Output Power (dBm)	5.67	7.14	6.07	Р

**Conclusion: PASS** 



## A.3. Frequency Band Edges – Conducted

#### Method of Measurement: See ANSI C63.10-clause 7.8.6

Connect the spectrum analyzer to the EUT using an appropriate RF cable connected to the EUT output. Configure the spectrum analyzer settings as described below (be sure to enter all losses between the unlicensed wireless device output and the spectrum analyzer).

- Span: 10 MHz

Resolution Bandwidth: 100 kHzVideo Bandwidth: 300 kHz

Sweep Time: 5msDetector: PeakTrace: max hold

Place a marker at the end of the restricted band closest to the transmit frequency to show compliance. Also measure any emissions in the restricted bands. Save the spectrum analyzer plot. Repeat for each power and modulation for lowest and highest channel.

Observe the stored trace and measure the amplitude delta between the peak of the fundamental and the peak of the band-edge emission. This is not an absolute field strength measurement; it is only a relative measurement to determine the amount by which the emission drops at the band edge relative to the highest fundamental emission level.

#### **Measurement Limit:**

Standard	Limit (dBc)
FCC 47 CFR Part 15.247 (d)	< -20

#### **Measurement Result:**

#### For GFSK

Channel	Hopping	Band Edge Power ( dBc)		Conclusion
0	Hopping OFF	Fig.1	-48.29	Р
0	Hopping ON	Fig.2	-62.82	Р
70	Hopping OFF	Fig.3	-55.42	Р
78	Hopping ON	Fig.4	-66.19	Р

#### Forπ/4 DQPSK

Channel	Hopping	Band Edge Power ( dBc)		Conclusion
0	Hopping OFF	Fig.5	-51.88	Р
0	Hopping ON	Fig.6	-62.16	Р
70	Hopping OFF	Fig.7	-57.21	Р
78	Hopping ON	Fig.8	-65.60	Р

#### For 8DPSK

Channel	Hopping	Band Edge Power ( dBc)		Conclusion
0	Hopping OFF	Fig.9	-51.65	Р
0	Hopping ON	Fig.10	-59.95	Р



70	Hopping OFF	Fig.11	-56.37	Р
70	Hopping ON	Fig.12	-66.11	Р

Conclusion: PASS
Test graphs as below

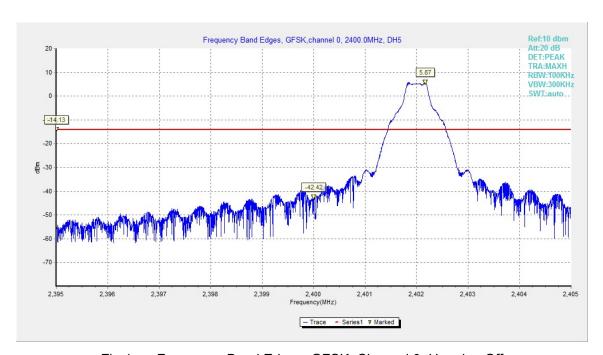


Fig.1. Frequency Band Edges: GFSK, Channel 0, Hopping Off

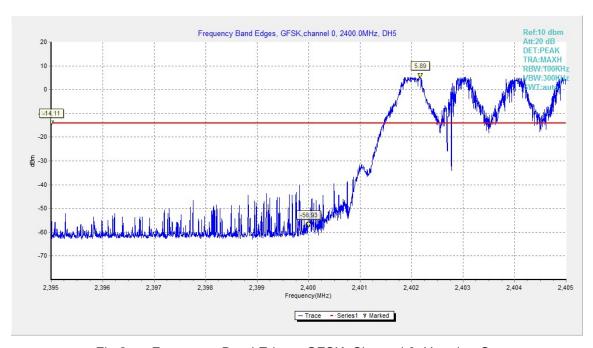


Fig.2. Frequency Band Edges: GFSK, Channel 0, Hopping On



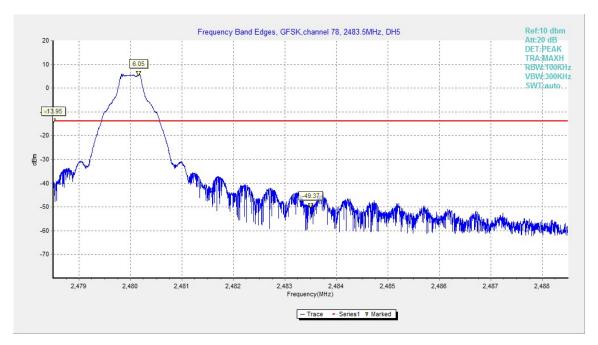


Fig.3. Frequency Band Edges: GFSK, Channel 78, Hopping Off

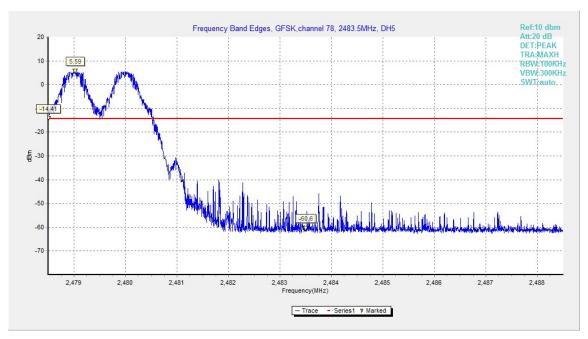


Fig.4. Frequency Band Edges: GFSK, Channel 78, Hopping On



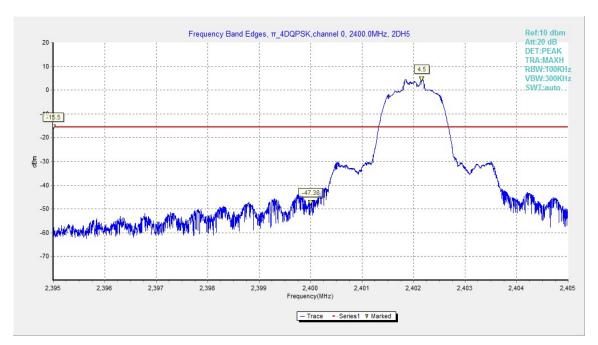


Fig.5. Frequency Band Edges:  $\pi/4$  DQPSK, Channel 0, Hopping Off

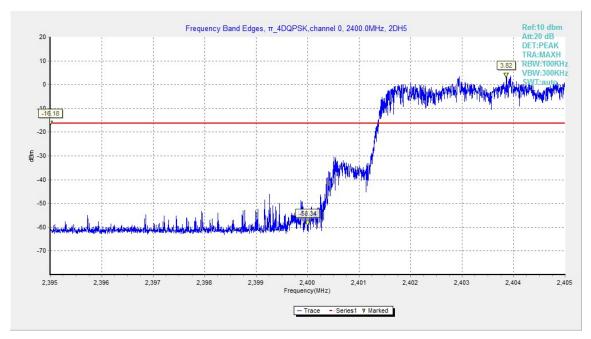


Fig.6. Frequency Band Edges: π/4 DQPSK, Channel 0, Hopping On



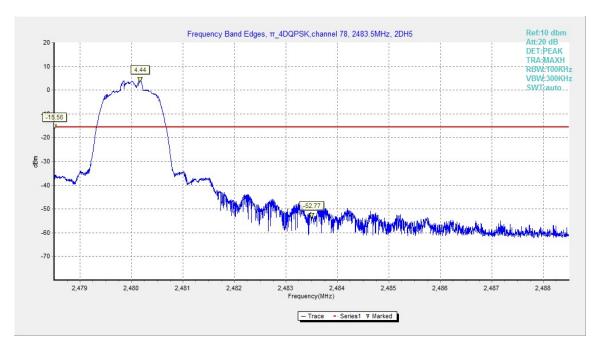


Fig.7. Frequency Band Edges:  $\pi/4$  DQPSK, Channel 78, Hopping Off

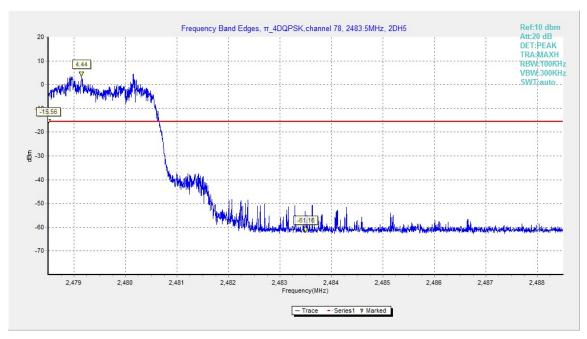


Fig.8. Frequency Band Edges:  $\pi/4$  DQPSK, Channel 78, Hopping On



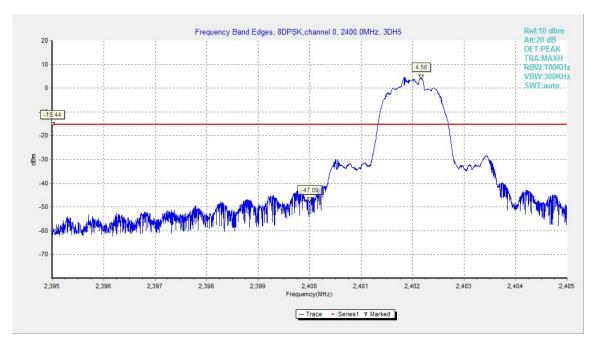


Fig.9. Frequency Band Edges: 8DPSK, Channel 0, Hopping Off

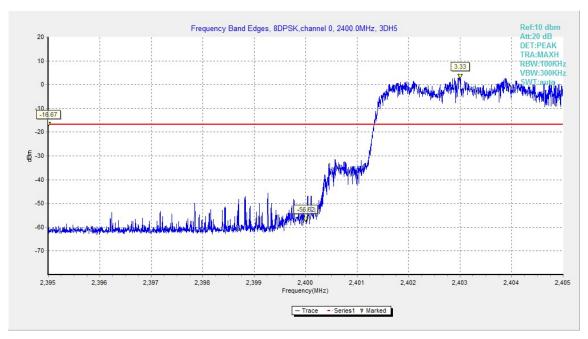


Fig.10. Frequency Band Edges: 8DPSK, Channel 0, Hopping On



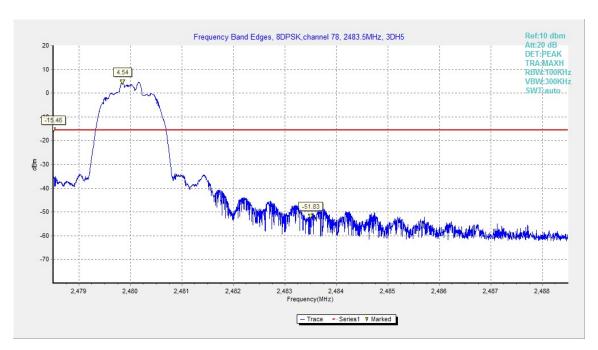


Fig.11. Frequency Band Edges: 8DPSK, Channel 78, Hopping Off

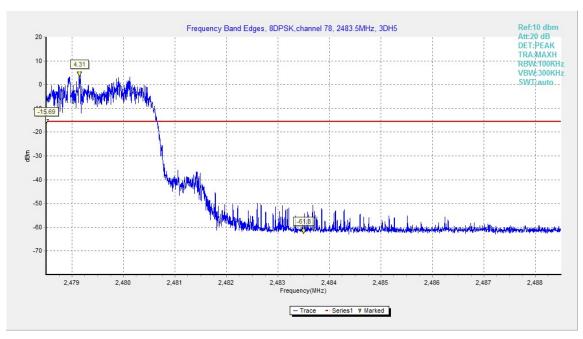


Fig.12. Frequency Band Edges: 8DPSK, Channel 78, Hopping On



#### A.4. Conducted Emission

#### Method of Measurement: See ANSI C63.10-clause 7.8.8

Measurement Procedure - Reference Level

- 1. Set the RBW = 100 kHz.
- 2. Set the VBW = 300 kHz.
- 3. Set the span to 5-30 % greater than the EBW.
- 4. Detector = peak.
- 5. Sweep time = auto couple.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.
- 8. Use the peak marker function to determine the maximum power level in any 100 kHz band segment within the fundamental EBW. Next, determine the power in 100 kHz band segments outside of the authorized frequency band using the following measurement:

Measurement Procedure - Unwanted Emissions

- 1. Set RBW = 100 kHz.
- 2. Set VBW = 300 kHz.
- 3. Set span to encompass the spectrum to be examined.
- 4. Detector = peak.
- 5. Trace Mode = max hold.
- 6. Sweep = auto couple.
- 7. Allow the trace to stabilize (this may take some time, depending on the extent of the span).

Ensure that the amplitude of all unwanted emissions outside of the authorized frequency band (excluding restricted frequency bands) is attenuated by at least the minimum requirements specified above.

#### **Measurement Limit:**

Standard	Limit	
FCC 47 CFR Part 15.247 (d)	20dB below peak output power in 100 kHz	

#### Measurement Results:

#### For GFSK

Channel	Frequency Range	Test Results	Conclusion
Ch 0	Center Frequency	Fig.13	Р



2402 MHz	30 MHz ~ 1 GHz	Fig.14	Р
	1 GHz ~ 3 GHz	Fig.15	Р
	3 GHz ~ 10 GHz	Fig.16	Р
	10 GHz ~ 26 GHz	Fig.17	Р
	Center Frequency	Fig.18	Р
01.00	30 MHz ~ 1 GHz	Fig.19	Р
Ch 39 2441 MHz	1 GHz ~ 3 GHz	Fig.20	Р
2441 1011 12	3 GHz ~ 10 GHz	Fig.21	Р
	10 GHz ~ 26 GHz	Fig.22	Р
Ch 78 2480 MHz	Center Frequency	Fig.23	Р
	30 MHz ~ 1 GHz	Fig.24	Р
	1 GHz ~ 3 GHz	Fig.25	Р
	3 GHz ~ 10 GHz	Fig.26	Р
	10 GHz ~ 26 GHz	Fig.27	Р

## For $\pi/4$ DQPSK

Channel	Frequency Range	Test Results	Conclusion
QL 0	Center Frequency	Fig.28	Р
	30 MHz ~ 1 GHz	Fig.29	Р
Ch 0 2402 MHz	1 GHz ~ 3 GHz	Fig.30	Р
2102 11112	3 GHz ~ 10 GHz	Fig.31	Р
	10 GHz ~ 26 GHz	Fig.32	Р
	Center Frequency	Fig.33	Р
01.00	30 MHz ~ 1 GHz	Fig.34	Р
Ch 39 2441 MHz	1 GHz ~ 3 GHz	Fig.35	Р
	3 GHz ~ 10 GHz	Fig.36	Р
	10 GHz ~ 26 GHz	Fig.37	Р
	Center Frequency	Fig.38	Р
Ch 78 2480 MHz	30 MHz ~ 1 GHz	Fig.39	Р
	1 GHz ~ 3 GHz	Fig.40	Р
	3 GHz ~ 10 GHz	Fig.41	Р
	10 GHz ~ 26 GHz	Fig.42	Р

### For 8DPSK

Channel	Frequency Range	Test Results	Conclusion
	Center Frequency	Fig.43	Р
Ch O	30 MHz ~ 1 GHz	Fig.44	Р
Ch 0 2402 MHz	1 GHz ~ 3 GHz	Fig.45	Р
	3 GHz ~ 10 GHz	Fig.46	Р
	10 GHz ~ 26 GHz	Fig.47	Р



Ch 39 2441 MHz	Center Frequency	Fig.48	Р
	30 MHz ~ 1 GHz	Fig.49	Р
	1 GHz ~ 3 GHz	Fig.50	Р
	3 GHz ~ 10 GHz	Fig.51	Р
	10 GHz ~ 26 GHz	Fig.52	Р
Ch 78 2480 MHz	Center Frequency	Fig.53	Р
	30 MHz ~ 1 GHz	Fig.54	Р
	1 GHz ~ 3 GHz	Fig.55	Р
	3 GHz ~ 10 GHz	Fig.56	Р
	10 GHz ~ 26 GHz	Fig.57	Р

Conclusion: PASS
Test graphs as below

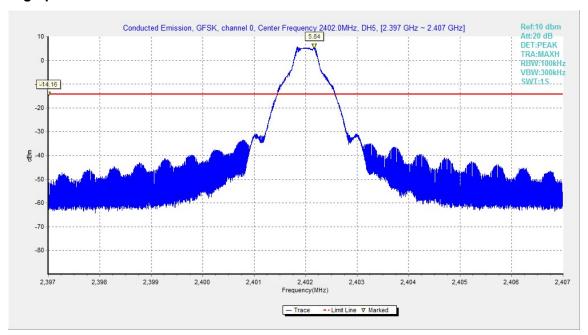


Fig.13. Conducted spurious emission: GFSK, Channel 0,2402MHz



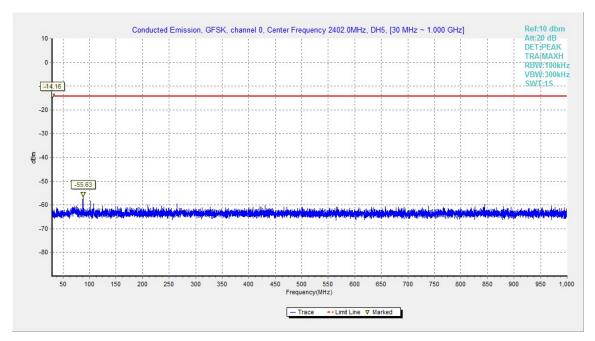


Fig.14. Conducted spurious emission: GFSK, Channel 0, 30MHz - 1GHz

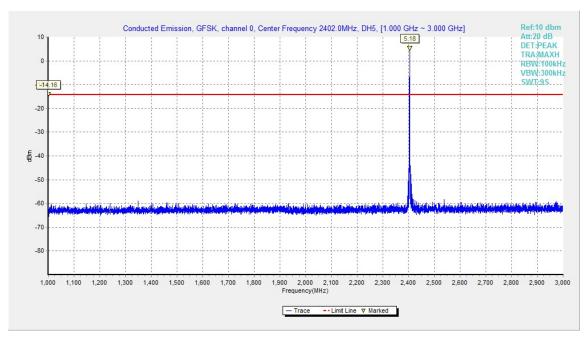


Fig.15. Conducted spurious emission: GFSK, Channel 0, 1GHz - 3GHz



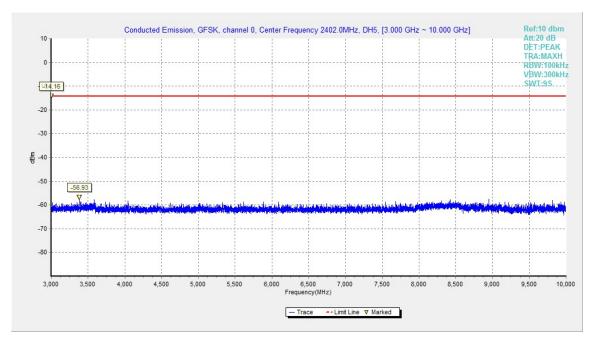


Fig.16. Conducted spurious emission: GFSK, Channel 0, 3GHz - 10GHz

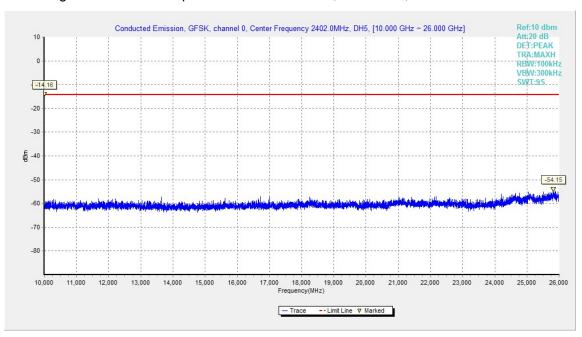


Fig.17. Conducted spurious emission: GFSK, Channel 0,10GHz - 26GHz



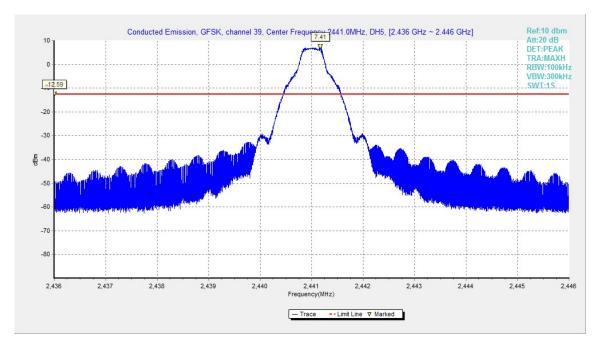


Fig.18. Conducted spurious emission: GFSK, Channel 39, 2441MHz

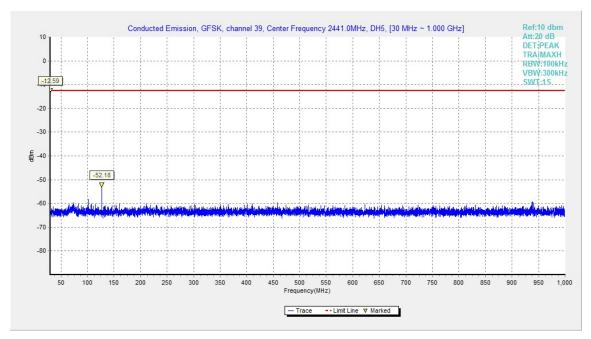


Fig.19. Conducted spurious emission: GFSK, Channel 39, 30MHz - 1GHz



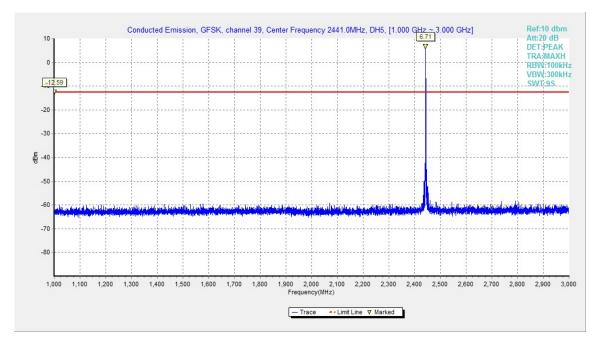


Fig.20. Conducted spurious emission: GFSK, Channel 39, 1GHz – 3GHz

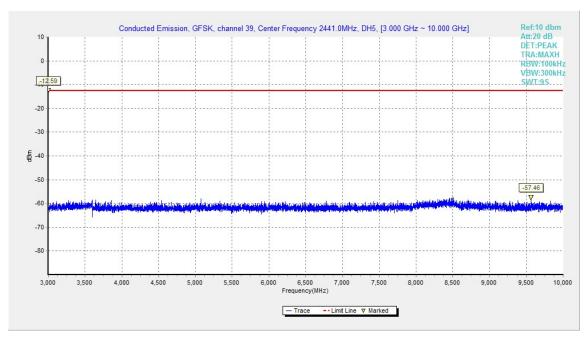


Fig.21. Conducted spurious emission: GFSK, Channel 39, 3GHz – 10GHz



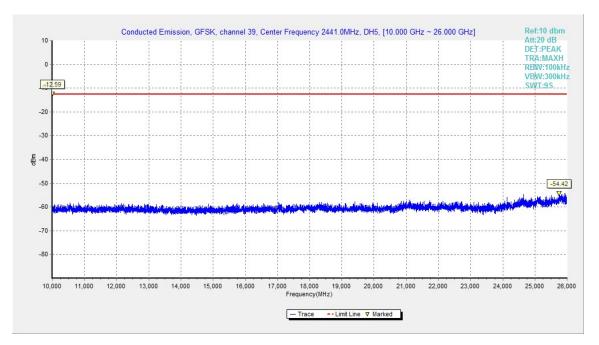


Fig.22. Conducted spurious emission: GFSK, Channel 39, 10GHz – 26GHz

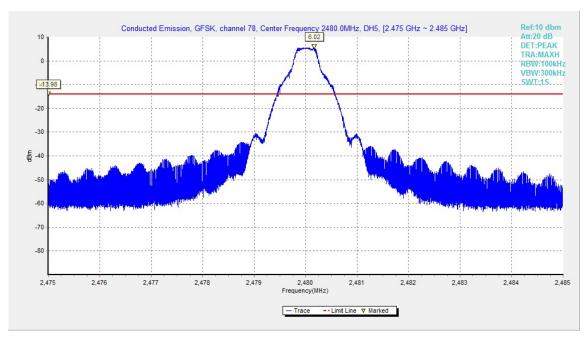


Fig.23. Conducted spurious emission: GFSK, Channel 78, 2480MHz



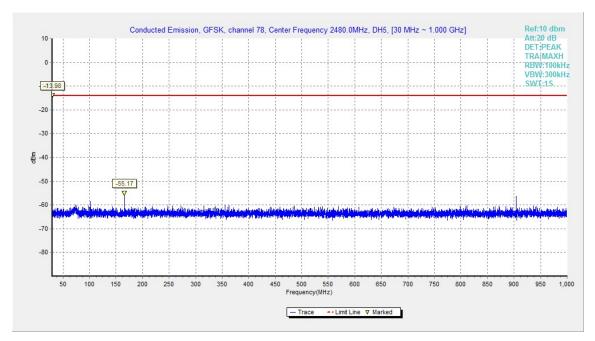


Fig.24. Conducted spurious emission: GFSK, Channel 78, 30MHz - 1GHz

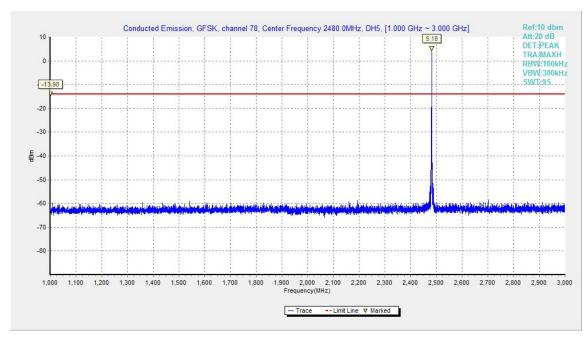


Fig.25. Conducted spurious emission: GFSK, Channel 78, 1GHz - 3GHz



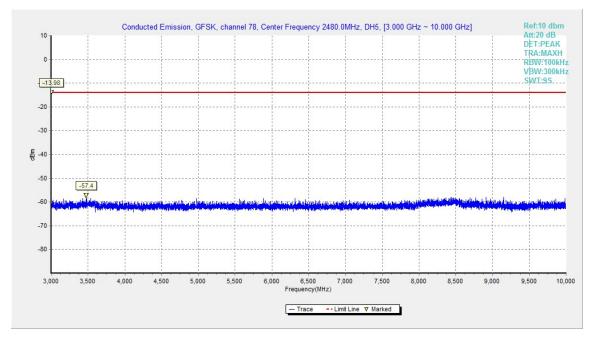


Fig.26. Conducted spurious emission: GFSK, Channel 78, 3GHz - 10GHz

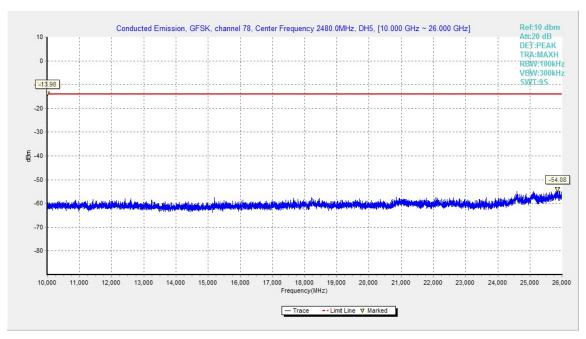


Fig.27. Conducted spurious emission: GFSK, Channel 78, 10GHz - 26GHz



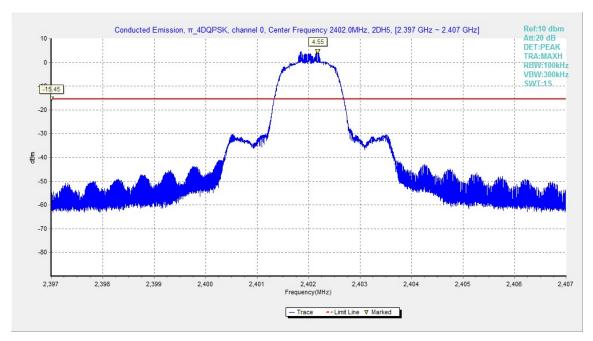


Fig.28. Conducted spurious emission:  $\pi/4$  DQPSK, Channel 0,2402MHz

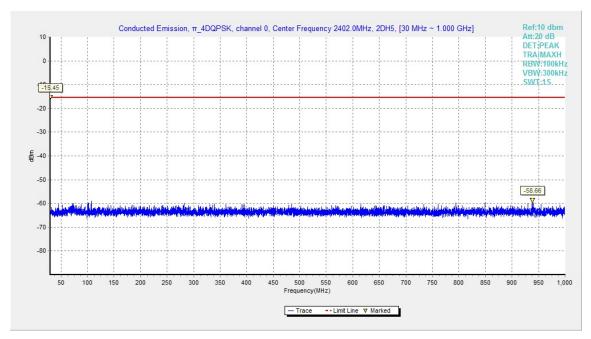


Fig.29. Conducted spurious emission:  $\pi/4$  DQPSK, Channel 0, 30MHz - 1GHz